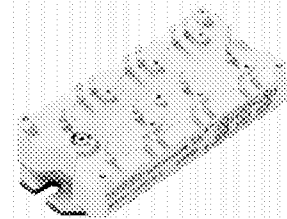


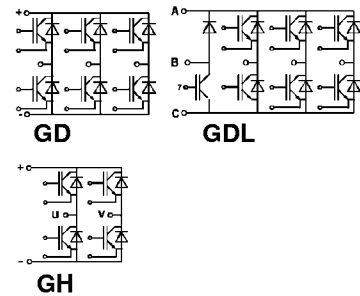
Absolute Maximum Ratings		Values	Units
Symbol	Conditions ¹⁾		
V _{CEs}		600	V
V _{GGR}	R _{GE} = 20 kΩ	600	V
I _C	T _{case} = 25/75 °C	70 / 50	A
I _{CM}	T _{case} = 25/75 °C; t _p = 1 ms	140 / 100	A
V _{GES}		± 20	V
P _{tot}	per IGBT, T _{case} = 25 °C	250	W
T _j , (T _{stg})		-40 ... +150 (125)	°C
V _{isol}	AC, 1 min.	2500	V
humidity	DIN 40040	Class F	
climate	DIN IEC 68 T.1	40/125/56	
Inverse Diode			
I _F = -I _C	T _{case} = 25/80 °C	75 / 50	A
I _{FM} = -I _{CM}	T _{case} = 25/80 °C; t _p = 1 ms	140 / 100	A
I _{FSM}	t _p = 10 ms; sin.; T _j = 150 °C	440	A
I ² t	t _p = 10 ms; T _j = 150 °C	970	A ² s

SEMITRANS® Superfast NPT-IGBT Modules

SKM 50 GD 063 DL
SKM 50 GDL 063 D)**
SKM 50 GH 063 DL *)**



SIXPACK / 7-Pack) / 4-Pack***)**



Characteristics		min.	typ.	max.	Units
Symbol	Conditions ¹⁾				
V _{(BR)CES}	V _{GE} = 0, I _C = 1,5 mA	≥ V _{CEs}	-	-	V
V _{GE(th)}	V _{GE} = V _{CE} , I _C = 1 mA	4,5	5,5	6,5	V
I _{CES}	V _{GE} = 0 } T _j = 25 °C	-	0,1	1,5	mA
	V _{CE} = V _{CEs} } T _j = 125 °C	-	3	-	mA
I _{GES}	V _{GE} = 20 V, V _{CE} = 0	-	-	100	nA
V _{CEsat}	I _C = 30 A } V _{GE} = 15 V;	-	1,8(2,0)	-	V
V _{CEsat}	I _C = 50 A } T _j = 25 (125) °C }	-	2,1(2,4)	2,5(2,8)	V
g _{fs}	V _{CE} = 20 V, I _C = 50 A	20	-	-	S
C _{CHC}	per IGBT	-	-	350	pF
C _{ies}	V _{GE} = 0	-	2800	-	pF
C _{oes}	V _{CE} = 25 V	-	300	-	pF
C _{res}	f = 1 MHz	-	200	-	pF
L _{CE}		-	-	60	nH
t _{d(on)}	V _{CC} = 300 V	-	50	-	ns
t _r	V _{GE} = -15 V / +15 V ³⁾	-	40	-	ns
t _{d(off)}	I _C = 50 A, ind. load	-	300	-	ns
t _f	R _{Gon} = R _{Goff} = 22 Ω	-	30	-	ns
E _{on}	T _j = 125 °C	-	2,5	-	mWs
E _{off}		-	1,8	-	mWs
Inverse Diode ⁸⁾					
V _F = V _{EC}	I _F = 50 A } V _{GE} = 0 V;	-	1,45(1,35)	1,7	V
	T _j = 25 (125 °C) }				
V _{TO}	T _j = 125 °C	-	-	0,9	V
r _t	T _j = 125 °C	-	10	15	mΩ
I _{RRM}	I _F = 50 A; T _j = 125 °C ²⁾	-	31	-	A
Q _{rr}	I _F = 50 A; T _j = 125 °C ²⁾	-	3,2	-	μC
Thermal characteristics					
R _{thjc}	per IGBT	-	-	0,5	°C/W
R _{thjc}	per diode	-	-	1,0	°C/W
R _{thch}	per module	-	-	0,05	°C/W

Diagrams Fig. 1 to 24 of type SKM 50GB063D apply

***) 7-pack = three phase inverter plus brake chopper

****) 4-pack, branch W left off

¹⁾ T_{case} = 25 °C, unless otherwise specified

²⁾ I_F = -I_C, V_R = 300 V, -di_F/dt = 800 A/μs, V_{GE} = 0 V

³⁾ Use V_{GEoff} = -5... -15 V

⁸⁾ CAL = Controlled Axial Lifetime Technology

⁹⁾ Compared to PT-IGBT

Features

- N channel, homogeneous Silicon structure (NPT- Non punch-through IGBT)
- Low tail current with low temperature dependence
- High short circuit capability, self limiting if term. G is clamped to E
- Pos. temp.-coeff. of V_{CEsat}
- 50 % less turn off losses ⁹⁾
- 30 % less short circuit current ⁹⁾
- Very low C_{ies}, C_{oes}, C_{res} ⁹⁾
- Latch-up free
- Fast & soft inverse CAL diodes ⁸⁾
- Isolated copper baseplate using DCB Direct Copper Bonding Technology without hard mould
- Large clearance (9 mm) and creepage distances (13 mm)

Typical Applications

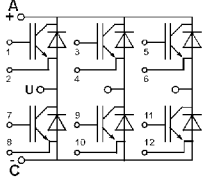
- Switching (not for linear use)
- Switched mode power supplies
- UPS
- Three phase inverters for servo / AC motor speed control
- Pulse frequencies also > 10 kHz

Cases and mech. data → B 6 – 14

SKM 50 GD 063 DL...

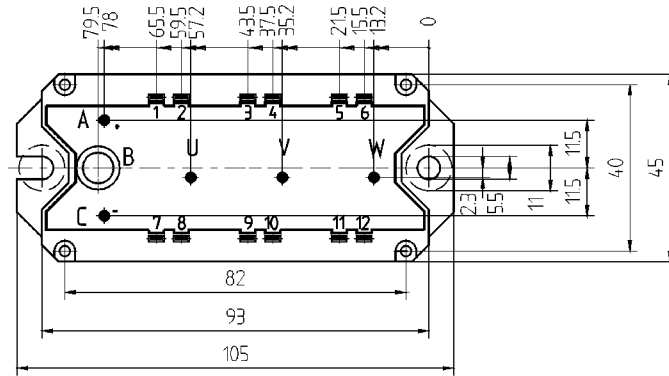
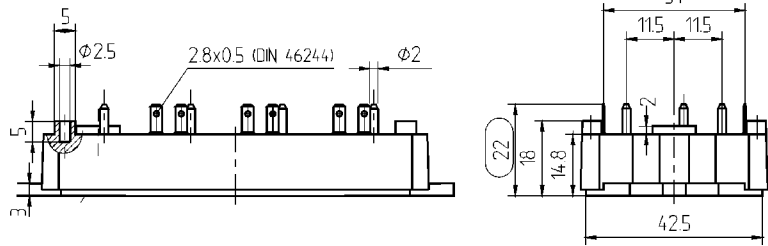
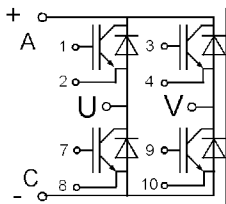
SEMISTRANS® Sixpack

Case D 68
UL Recognized
File no. E 63 532
SKM 50 GD 063 DL



SKM 50 GH 063 DL

Case D77 (= D68 without terminal W)

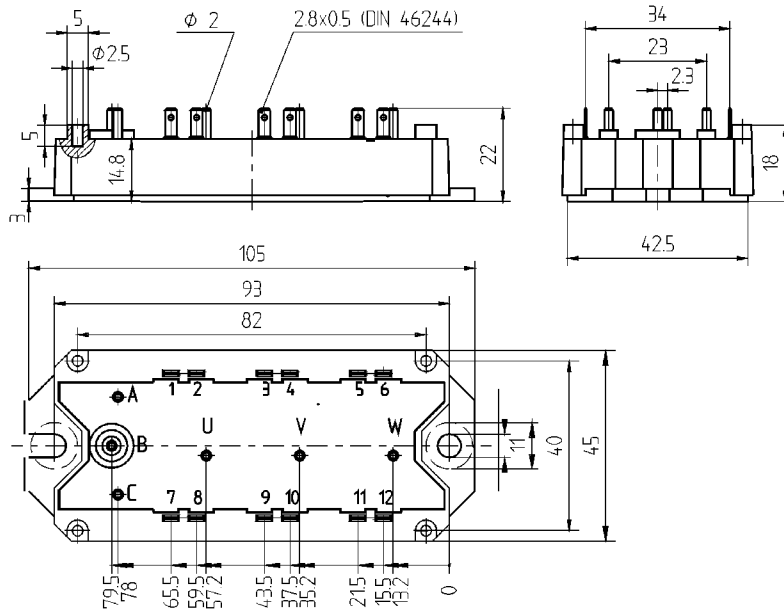
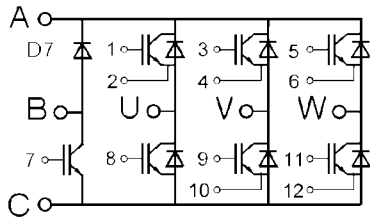


SEMISTRANS® Sevenpack

Case D 73
UL Recognized
File no. E 63 532

SKM 50 GDL 063 D

0000DL



Dimensions in mm

Case outlines and circuit diagrams

Mechanical Data		Values			Units
Symbol	Conditions	min.	typ.	max.	
M ₁	to heatsink, SI Units (M5)	4	—	5	Nm
a	to heatsink, US Units	35	—	44	lb.in.
w		—	—	5x9,81	m/s ²
		—	—	175	g

This is an electrostatic discharge sensitive device (ESDS). Please observe the international standard IEC 747-1, Chapter IX.

Two devices are supplied in one SEMIBOX A. Larger packing units (10 or 20 pieces) are used if suitable SEMIBOX → page C - 1.

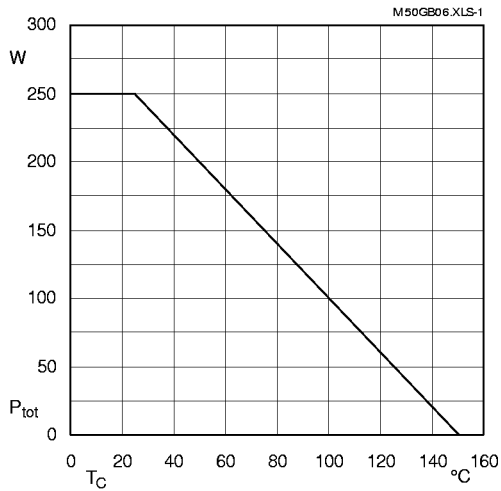


Fig. 1 Rated power dissipation $P_{tot} = f(T_C)$

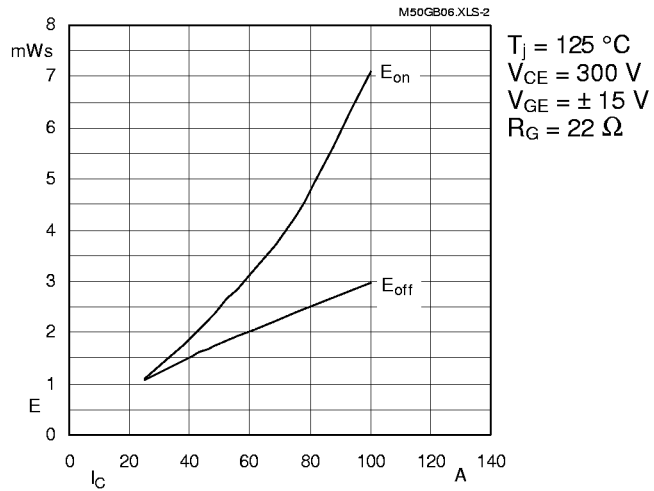


Fig. 2 Turn-on /-off energy $= f(I_C)$

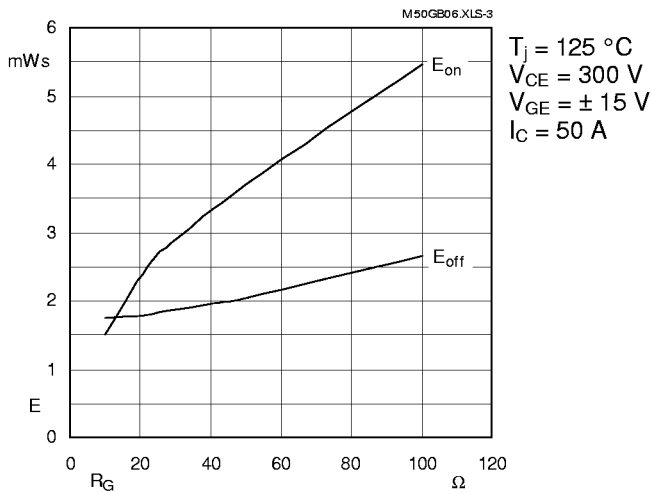


Fig. 3 Turn-on /-off energy $= f(R_G)$

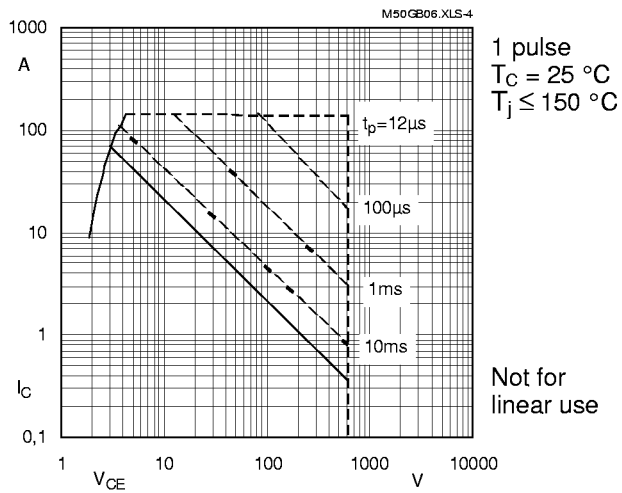


Fig. 4 Maximum safe operating area (SOA) $I_C = f(V_{CE})$

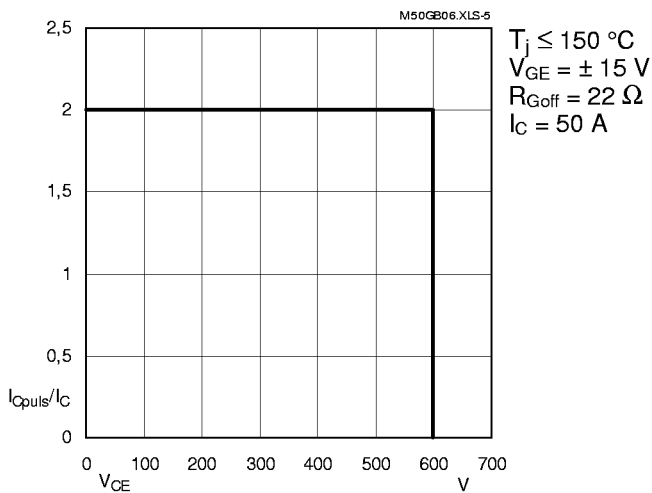


Fig. 5 Turn-off safe operating area (RBSOA)

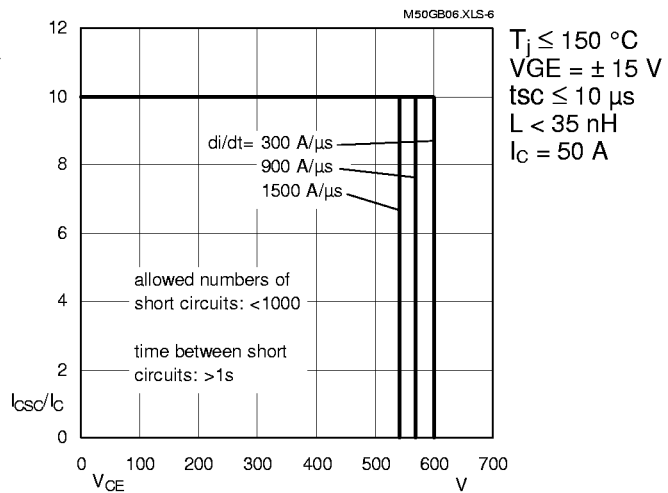


Fig. 6 Safe operating area at short circuit $I_C = f(V_{CE})$

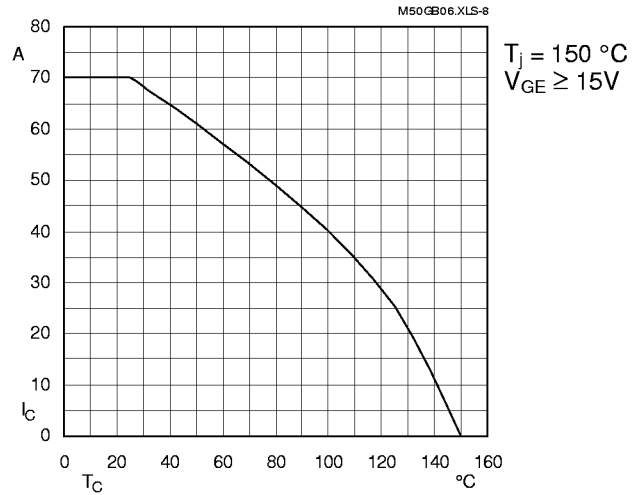


Fig. 8 Rated current vs. temperature $I_C = f(T_C)$

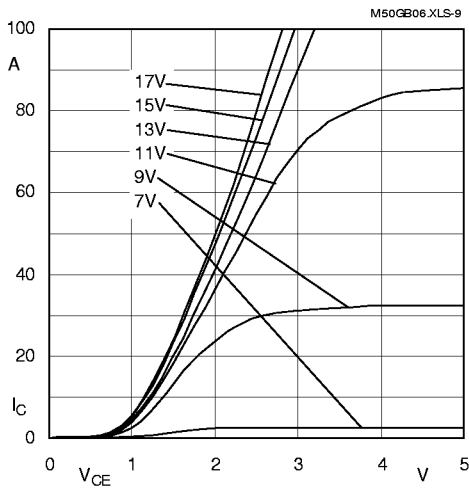


Fig. 9 Typ. output characteristic, $t_p = 250 \mu s$; $T_j = 25 \text{ }^\circ\text{C}$

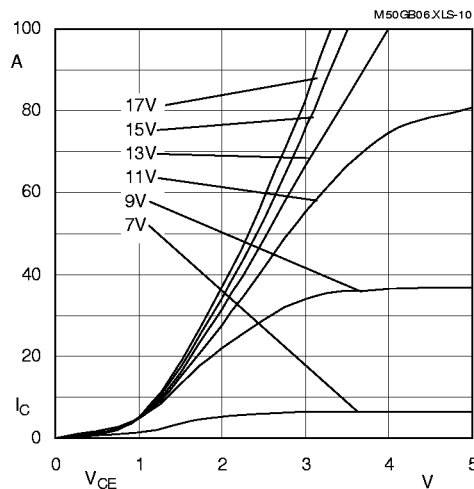


Fig. 10 Typ. output characteristic, $t_p = 250 \mu s$; $T_j = 125 \text{ }^\circ\text{C}$

$$P_{\text{cond}(t)} = V_{\text{CEsat}(t)} \cdot I_{\text{C}(t)}$$

$$V_{\text{CEsat}(t)} = V_{\text{CE(TO)(Tj)}} + r_{\text{CE(Tj)}} \cdot I_{\text{C}(t)}$$

$$V_{\text{CE(TO)(Tj)}} \leq 1,2 - 0,001 (T_j - 25) \text{ [V]}$$

$$\text{typ.: } r_{\text{CE(Tj)}} = 0,018 + 0,00008 (T_j - 25) \text{ [\Omega]}$$

$$\text{max.: } r_{\text{CE(Tj)}} = 0,026 + 0,00008 (T_j - 25) \text{ [\Omega]}$$

$$\text{valid for } V_{\text{GE}} = +15 \begin{matrix} +2 \\ -1 \end{matrix} \text{ [V]; } I_{\text{C}} \geq 0,3 I_{\text{Cnom}}$$

Fig. 11 Saturation characteristic (IGBT)
Calculation elements and equations

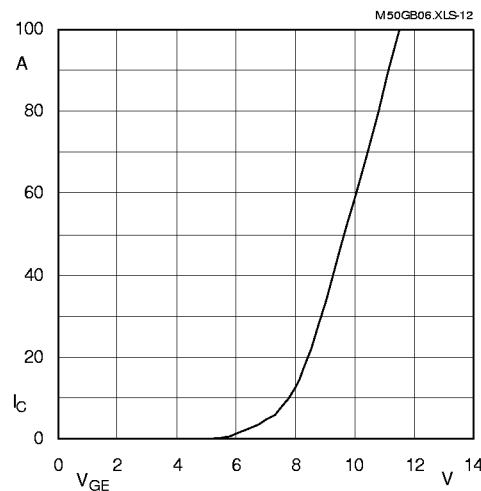


Fig. 12 Typ. transfer characteristic, $t_p = 80 \mu s$; $V_{\text{CE}} = 20 \text{ V}$

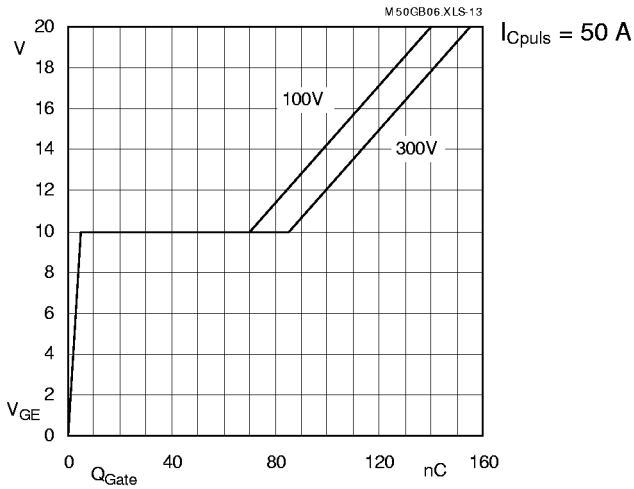


Fig. 13 Typ. gate charge characteristic

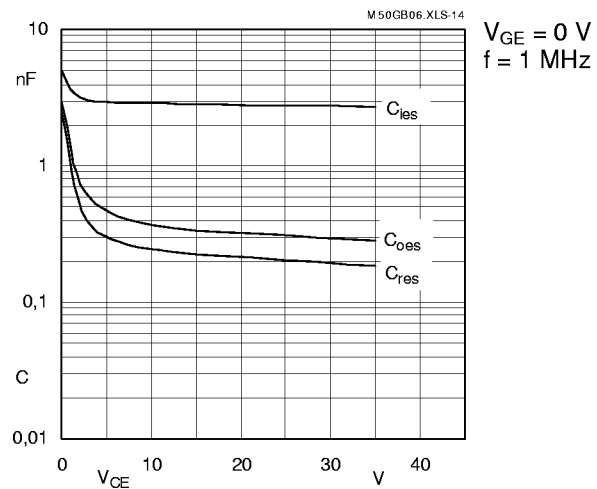


Fig. 14 Typ. capacitances vs. V_{CE}

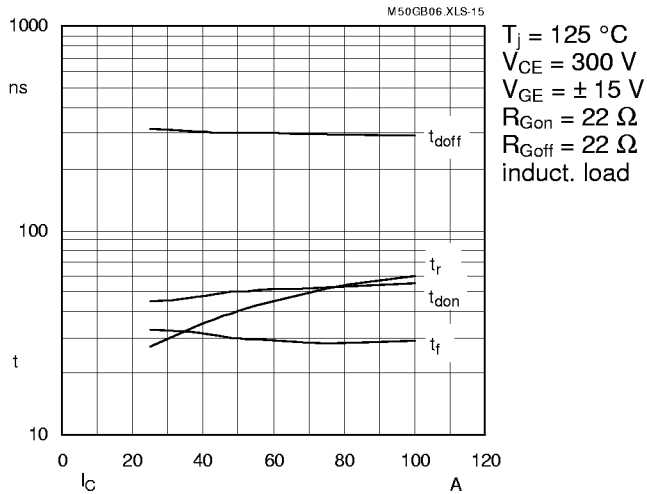


Fig. 15 Typ. switching times vs. I_C

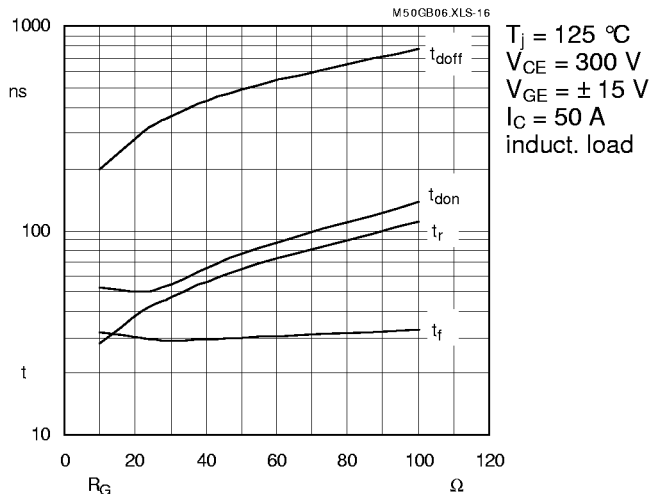


Fig. 16 Typ. switching times vs. gate resistor R_G

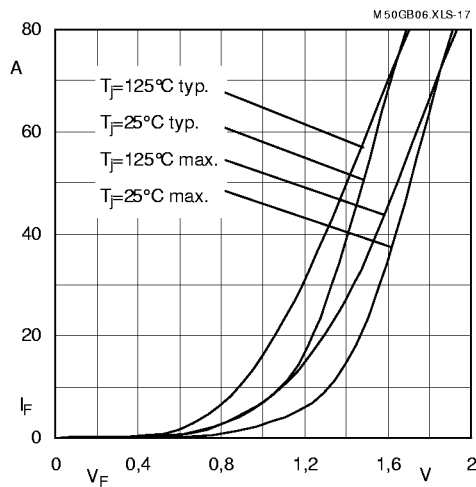


Fig. 17 Typ. CAL diode forward characteristic

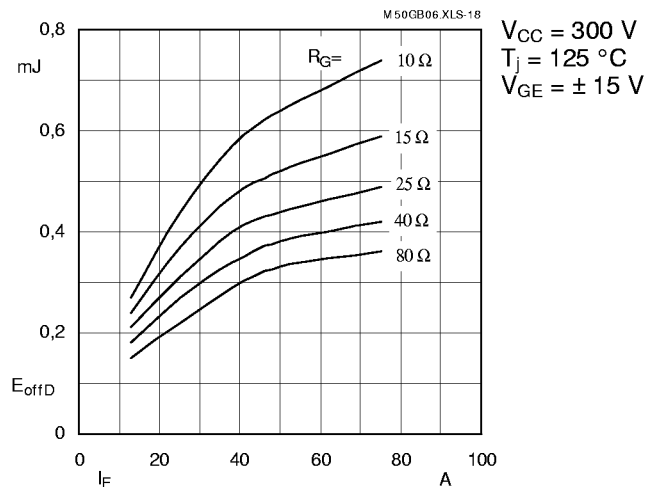


Fig. 18 Diode turn-off energy dissipation per pulse

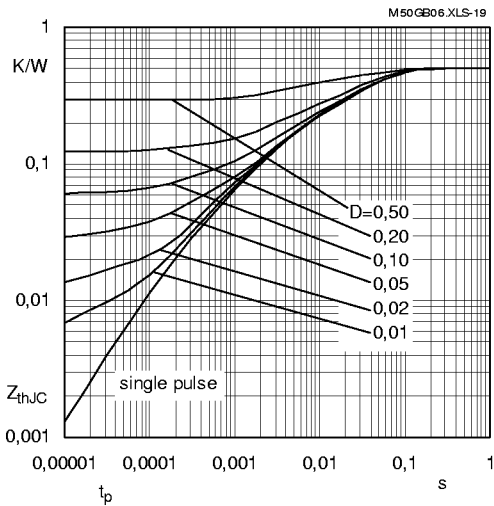


Fig. 19 Transient thermal impedance of IGBT
 $Z_{thJC} = f(t_p)$; $D = t_p / t_c = t_p \cdot f$

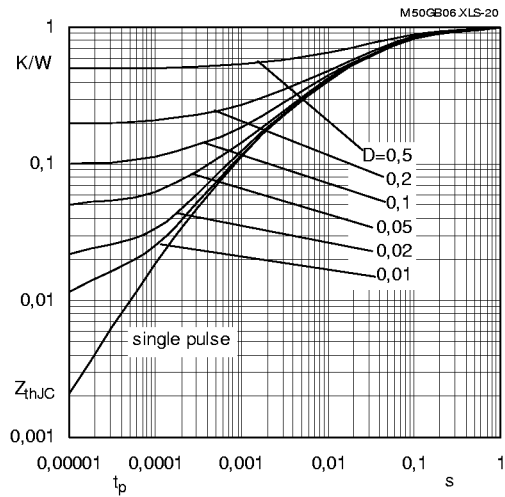
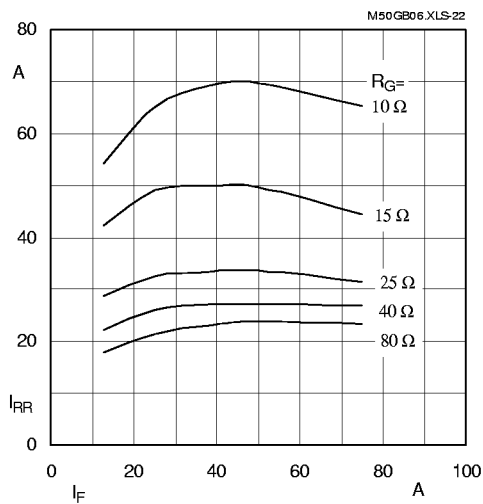
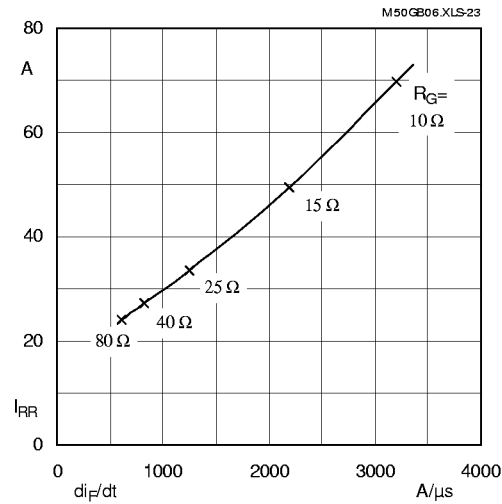


Fig. 20 Transient thermal impedance of inverse CAL diodes
 $Z_{thJC} = f(t_p)$; $D = t_p / t_c = t_p \cdot f$



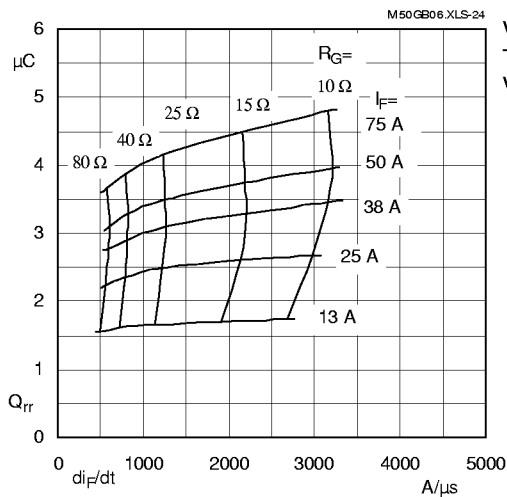
$V_{CC} = 300 \text{ V}$
 $T_j = 125 \text{ °C}$
 $V_{GE} = \pm 15 \text{ V}$

Fig. 22 Typ. CAL diode peak reverse recovery current $I_{RR} = f(I_F; R_G)$



$V_{CC} = 300 \text{ V}$
 $T_j = 125 \text{ °C}$
 $V_{GE} = \pm 15 \text{ V}$
 $I_F = 50 \text{ A}$

Fig. 23 Typ. CAL diode peak reverse recovery current $I_{RR} = f(di_F/dt)$



$V_{CC} = 300 \text{ V}$
 $T_j = 125 \text{ °C}$
 $V_{GE} = \pm 15 \text{ V}$

Fig. 24 Typ. CAL diode recovered charge